SDAS111 - D2661, APRIL 1982 - REVISED SEPTEMBER 1987

- Package Options include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas instruments Quality and Reliability

description

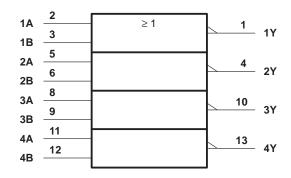
These devices contain four independent 2-input NOR gates. They perform the Boolean functions $Y = \overline{A} \cdot \overline{B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

The SN54ALS02 and SN54AS02 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS02 and SN74AS02 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

INP	JTS	OUTPUT
Α	В	Y
Н	Х	L
Х	Н	L
L	L	Н

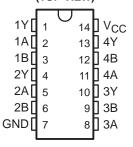
logic symbol†



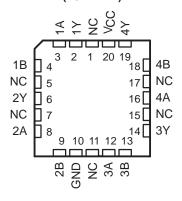
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

SN54ALS02, SN54AS02 . . . J PACKAGE SN74ALS02, SN74AS02 . . . D OR N PACKAGE (TOP VIEW)

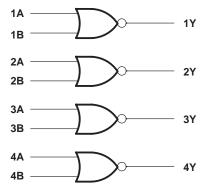


SN54ALS02, SN54AS02 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



SDAS111 - D2661, APRIL 1982 - REVISED SEPTEMBER 1987

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}		 7 V
Input voltage		 7 V
Operating free-air temperature range:	SN54ALS02	 −55°C to 125°C
	SN74ALS02	 0°C to 70°C
Storage temperature range		 −65°C to 150°C

recommended operating conditions

		SI	N54ALS0)2	SN	174ALS0)2	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
							0.8	
VIL	Low-level input voltage			0.8†				V
				0.7‡				
IOH	High-level output current			-0.4			-0.4	mA
lOL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

[†] Tested at -55°C to 70°C.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	SN54ALS02			SN74ALS02		
PARAMETER	TEST CONL	DITIONS	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.5			-1.5	V
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2						V
Voi	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
VOL	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 8 \text{ mA}$					0.35	0.5	V
lį	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
lіН	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
I _{IL}	$V_{CC} = 5.5 V,$	V _I = 0.4 V			-0.1			-0.1	mA
ΙΟ [¶]	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA
Іссн	V _{CC} = 5.5 V,	V _I = 0 V		0.86	2.2		0.86	2.2	mA
ICCL	V _{CC} = 5.5 V,	V _I = 4.5 V		2.16	4		2.16	4	mA

 $[\]S$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Note 1)

PARAMETER FROM (INPUT)		TO (OUTPUT)	$V_{CC} = 5 \text{ V},$ $C_{L} = pF,$ $R_{L} = 500 \Omega,$ $T_{A} = 25^{\circ}C$	F	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX#				
			'ALS02	SN54A	LS02	SN54A	LS02		
			TYP	MIN	MAX	MIN	MAX		
t _{PLH}	A or B	Υ	7	1	16	3	12	ns	
^t PHL	A or B	Υ	5	1	7.5	3	7.58	ns	

[#] For conditions shown MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 1: Load circuit and Voltage waveforms are shown in Section 1 of the *ALS/AS Logic Data Book*, 1986.



[‡] Tested at 70°C to 125°C, per MIL-STD-833, method 5005, sub-group 1, 2, and 3. Static test is performed at 25°C, 125°C, and –55°C.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SDAS111 - D2661, APRIL 1982 - REVISED SEPTEMBER 1987

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

recommended operating conditions

		S	N54AS0	2	S	N74AS0	2	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
٧ıH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
loh	High-level output current			-2			-2	mA
loL	Low-level output current			20			20	mA
T _A	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating-free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS		SN	SN54AS02			SN74AS02			
PARAMETER	IESI CONI	DITIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
Voн	$V_{CC} = 4.5 \text{ V to } 5.5 \text{V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2			V	
V _{OL}	V _{CC} = 4.5 V,	$I_{OL} = 20 \text{ mA}$		0.35	0.5		0.35	0.5	V	
lį	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA	
lіН	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ	
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.5			-0.5	mA	
IO [‡]	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
^I ссн	$V_{CC} = 5.5 V,$	$V_I = 0 V$		3.7	5.9		3.7	5.9	mA	
ICCL	V _{CC} = 5.5 V,	V _I = 4.5 V		12.5	20.1		12.5	20.1	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	то (ОИТРИТ)	5N54A	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ $T_A = \text{MIN to MAX} $ $\text{SN54ALS02} \qquad \text{SN54ALS02}$		§ .LS02	UNIT
			MIN	MAX	MIN	MAX	
^t PLH	A or B	Y	1	5	1	4.5	ns
tPHL	A or B		1	5	- 1	4.5	ns

[§] For conditions shown MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 1: Load circuit and voltage waveforms are shown in Section 1 of the *ALS/AS Logic Data Book*, 1986.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated